

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under

Reexamination

FUKUDA ET AL.

Examiner

John P. Sheehan

Art Unit

1742

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,276,505	01-1994	Jeong, Jin K.	348/649
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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